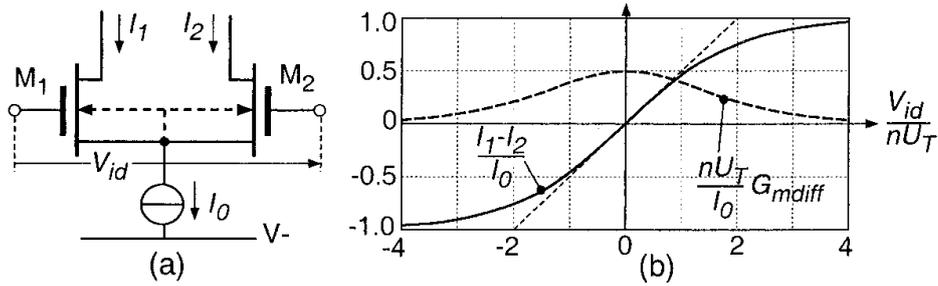


It should be noticed that, as explained at the end of Section 5.8.1, the source voltage should be as small as possible in order to eliminate the effect of  $\Delta n$  (mismatch of slope factors). This means that, for minimizing the input voltage offset, the two transistors should be put in a separate well connected to their sources, as illustrated in dotted line in Figure 8.3(a). In single-well processes, this is unfortunately only possible for one type of transistors (P-channel for N-well process).



**Fig. 8.3.** Differential pair; (a) circuit; (b) transfer characteristics and transconductance.

The transfer characteristics of the saturated differential pair in weak inversion can be calculated by using equation (5.40) of the drain current, giving

$$I_1 = \frac{I_0}{1 + \exp \frac{-V_{id}}{nU_T}} \quad \text{and} \quad I_2 = \frac{I_0}{1 + \exp \frac{+V_{id}}{nU_T}}, \quad (8.14)$$

or for the difference of output currents

$$I_1 - I_2 = I_0 \tanh \frac{V_{id}}{2nU_T}, \quad (8.15)$$

which is represented in Figure 8.3(b). As can be seen, a major drawback of a differential pair in weak inversion is its limited input range of linearity. This is best illustrated by the differential transconductance

$$G_{mdiff} = \frac{d(I_1 - I_2)}{dV_{id}} = \frac{I_0}{2nU_T} \cdot \left( \cosh \frac{V_{id}}{2nU_T} \right)^{-2} \quad (8.16)$$

plotted in the same figure.

The linear range can be extended by using the circuit of Figure 8.4(a) [164], which can be analyzed by means of the concept of pseudo-resistors introduced in Section 5.5, as shown by Figure 8.4(b). The saturated transistors  $M_1$  and  $M_2$  correspond to grounded resistors  $R_1$  and  $R_2$  in the resistor prototype. The linearization transistors  $M_{1a}$  and  $M_{2a}$  correspond to two resistors of  $K$ -times larger values. The difference of output currents can now be calculated by using the resistor prototype, giving